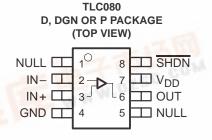
#### 查询TLC085供应商

# TLC080, TLC081, 世紀082章 世紀083; 世上0849 世紀085, TLC08xA FAMILY OF WIDE-BANDWIDTH HIGH-OUTPUT-DRIVE SINGLE SUPPLY OPERATIONAL AMPLIFIERS

SLOS254B - JUNE 1999 - REVISED NOVEMBER 1999

- Wide Bandwidth . . . 10 MHz
- High Output Drive

   I<sub>OH</sub>... 57 mA at V<sub>DD</sub> 1.5
   I<sub>OL</sub>... 55 mA at 0.5 V
- High Slew Rate
   SR+...16 V/μs
  - SR-... 19 V/µs
- Wide Supply Range . . . 4.5 V to 16 V
- Supply Current . . . 1.9 mA/Channel
- Ultra-Low Power Shutdown Mode
   I<sub>DD</sub>...125 μA/Channel
- Low Input Noise Voltage . . . 8.5 nV√Hz
- Wide V<sub>ICR</sub> . . . 0 to V<sub>DD</sub> 1
- Input Offset Voltage . . . 60 μV
- Ultra-Small Packages
   8 or 10 Pin MSOP (TLC080/1/2/3)



#### description

Introducing the first members of TI's new BiMOS general-purpose operational amplifier family—the TLC08x. The BiMOS family concept is simple: provide an upgrade path for BiFET users who are moving away from dual-supply to single-supply systems and demand higher ac and dc performance. With performance rated from 4.5 V to 16 V across commercial (0°C to 70°C) and an extended industrial temperature range (-40°C to 125°C), BiMOS suits a wide range of audio, automotive, industrial and instrumentation applications. Familiar features like offset nulling pins, and new features like MSOP PowerPAD<sup>™</sup> packages and shutdown modes, enable higher levels of performance in a multitude of applications.

Developed in TI's patented LBC3 BiCMOS process, the new BiMOS amplifiers combine a very high input impedance, low-noise CMOS front end with a high-drive Bipolar output stage—thus providing the optimum performance features of both. AC performance improvements over the TL08x BiFET predecessors include a bandwidth of 10 MHz (an increase of 300%) and voltage noise of 8.5 nV/ $\sqrt{\text{Hz}}$  (an improvement of 60%). DC improvements include an ensured V<sub>ICR</sub> that includes ground, a factor of 4 reduction in input offset voltage down to 1.5 mV (maximum) in the standard grade, and a power supply rejection improvement of greater than 40 dB to 130 dB. Added to this list of impressive features is the ability to drive ±50-mA loads comfortably from an ultra-small-footprint MSOP PowerPAD package, which positions the TLC08x as the ideal high-performance general-purpose operational amplifier family.

				ACKAGE	IADLE		and the second
DEVICE	NO. OF		PACKAG	E TYPES		SHUTDOWN	UNIVERSAL
DEVICE	CHANNELS	MSOP	PDIP	SOIC	TSSOP	SHUTDOWN	EVM BOARD
TLC080	1	8	8	8		Yes	
TLC081	1	8	8	8	—		
TLC082	2	8	8	8	—	—	Refer to the EVM Selection Guide
TLC083	2	10	14	14	—	Yes	(Lit# SLOU060)
TLC084	4	—	14	14	20	—	( ,
TLC085	4	_	16	16	20	Yes	

#### AMILY PACKAGE TABLE



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

VerPAD is a trademark of Texas Instruments Incorporated.



SLOS254B – JUNE 1999 – REVISED NOVEMBER 1999

	TLC080 and TLC081 AVAILABLE OPTIONS								
	PACKAGED DEVICES	PACKAGED DEVICES							
TA	SMALL OUTLINE (D) <sup>†</sup>	SMALL OUTLINE (DGN) <sup>†</sup>	SYMBOL	PLASTIC DIP (P)					
0°C to 70°C	TLC080CD TLC081CD	TLC080CDGN TLC081CDGN	xxTIACW xxTIACY	TLC080CP TLC081CP					
-40°C to 125°C	TLC080ID TLC081ID	TLC080IDGN TLC081IDGN	xxTIACX xxTIACZ	TLC080IP TLC081IP					
-40 0 10 123 0	TLC080AID TLC081AID	_		TLC080AIP TLC081AIP					

<sup>†</sup> This package is available taped and reeled. To order this packaging option, add an R suffix to the part number (e.g., TLC080CDR). <sup>‡</sup> Chip forms are tested at  $T_A = 25^{\circ}C$  only.

#### TLC082 and TLC083 AVAILABLE OPTIONS

		PACKAGED DEVICES							
TA	SMALL	MSOP			PLASTIC	PLASTIC			
	OUTLINE (D)†	(DGN)†	SYMBOL§	(DGQ)†	SYMBOL§	DIP (N)	DIP (P)		
0°C to 70°C	TLC082CD TLC083CD	TLC082CDGN —	xxTIADZ —		 xxTIAEB		TLC082CP —		
-40°C to 125°C	TLC082ID TLC083ID	TLC082IDGN —	xxTIAEA —		 xxTIAEC		TLC082IP —		
-40 0 10 125 0	TLC082AID TLC083AID	—					TLC082AIP —		

<sup>†</sup> This package is available taped and reeled. To order this packaging option, add an R suffix to the part number (e.g., TLC082CDR). <sup>‡</sup> Chip forms are tested at  $T_A = 25^{\circ}C$  only.

§ xx represents the device date code.

#### **TLC084 and TLC085 AVAILABLE OPTIONS**

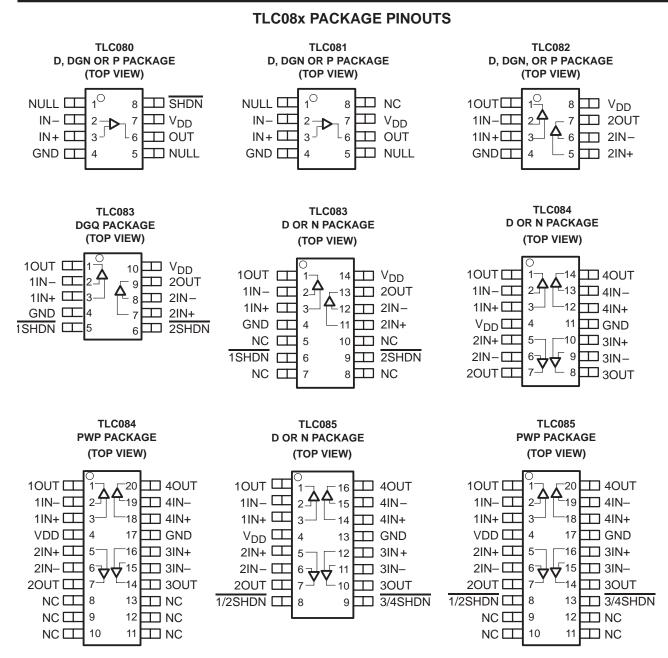
	PACKAGED DEVICES						
TA	SMALL OUTLINE	PLASTIC DIP	TSSOP				
	(D) <sup>†</sup>	(N)	(PWP)†				
0°C to 70°C	TLC084CD	TLC084CN	TLC084CPWP				
	TLC085CD	TLC085CN	TLC085CPWP				
−40°C to 125°C	TLC084ID	TLC084IN	TLC084IPWP				
	TLC085ID	TLC085IN	TLC085IPWP				
-40 0 10 123 0	TLC084AID	TLC084AIN	TLC084AIPWP				
	TLC085AID	TLC085AIN	TLC085AIPWP				

<sup>†</sup>This package is available taped and reeled. To order this packaging option, add an R suffix to the part number (e.g., TLC084CDR).

<sup>‡</sup> Chip forms are tested at  $T_A = 25^{\circ}C$  only.



SLOS254B – JUNE 1999 – REVISED NOVEMBER 1999



NC - No internal connection



SLOS254B – JUNE 1999 – REVISED NOVEMBER 1999

#### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)<sup>†</sup>

Supply voltage, V <sub>DD</sub> (see Note 1)	
Continuous total power dissipation	
Operating free-air temperature range, T <sub>A</sub> : C suffix	0°C to 70°C
I suffix	–40°C to 125°C
Maximum junction temperature, T <sub>J</sub>	150°C
Storage temperature range, T <sub>stg</sub>	−65°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE: All voltage values, except differential voltages, are with respect to GND.

PACKAGE	θJC (°C/W)	<sup>θ</sup> JA (°C/W)	T <sub>A</sub> ≤ 25°C POWER RATING
D (8)	38.3	176	710 mW
D (14)	26.9	122.3	1022 mW
D (16)	25.7	114.7	1090 mW
DGN (8)	4.7	52.7	2.37 W
DGQ (10)	4.7	52.3	2.39 W
N (14, 16)	32	78	1600 mW
P (8)	41	104	1200 mW
PWP (20)	1.40	26.1	4.79 W

#### **DISSIPATION RATING TABLE**

#### recommended operating conditions

		MIN	MAX	UNIT	
	Single supply	4.5	16	V	
Supply voltage, V <sub>DD</sub>		v			
Common-mode input voltage range, VICR		GND	V <sub>DD</sub> -1	V	
Derating free-air temperature, $T_A$	C-suffix	0	70	°C	
	I-suffix	-40	125		



# TLC080, TLC081, TLC082, TLC083, TLC084, TLC085, TLC08xA FAMILY OF WIDE-BANDWIDTH HIGH-OUTPUT-DRIVE SINGLE SUPPLY OPERATIONAL AMPLIFIERS SLOS254B – JUNE 1999 – REVISED NOVEMBER 1999

# electrical characteristics at specified free-air temperature, V<sub>DD</sub> = 5 V (unless otherwise noted)

	PARAMETER	TEST CO	NDITIONS	T <sub>A</sub> †	MIN	TYP	MAX	UNIT		
				25°C		60	1000			
			TLC080/1/2/3	Full range			1500			
			TI 0000 /4 /0 /0 A	25°C		20	750			
. /		V <sub>DD</sub> = 5 V,	TLC080/1/2/3A	Full range			1000			
VIO	Input offset voltage	$V_{\rm IC} = 2.5,$	TLC084/5	25°C		390	1900	μV		
		V <sub>O</sub> = 2.5,		Full range			3000			
		R <sub>S</sub> = 50 Ω		25°C		390	1400			
			TLC084/5A	Full range			2000			
αNIO	Temperature coefficient of input offset voltage					1.2		μV/°C		
			25°C	25°C		1.9	50			
IIO	Input offset current		TLC08XC				100	pА		
		$V_{DD} = 5 V,$ $V_{IC} = 2.5,$	TLC08XI	Full range			700			
		V <sub>O</sub> = 2.5,		25°C		3	50	0		
I <sub>IB</sub>	Input bias current	R <sub>S</sub> = 50 Ω	TLC08XC				100	pА		
			TLC08XI	Full range			700			
Common-mode input voltage VICR range	CMRR > 70 dB,	R <sub>S</sub> = 50 Ω	25°C	0 to 3.5						
		CMRR > 52 dB,	R <sub>S</sub> = 50 Ω	Full range	0 to 3.5			V		
				25°C	4.1	4.3				
			$I_{OH} = -1 \text{ mA}$	Full range	3.9					
						25°C	3.7	4		
			I <sub>OH</sub> = -20 mA	Full range	3.5					
Vон	High-level output voltage	V <sub>IC</sub> = 2.5 V		25°C	3.4	3.8		V		
			I <sub>OH</sub> = -35 mA	Full range	3.2					
				25°C	3.2	3.6				
			I <sub>OH</sub> = -50 mA	-40°C to 85°C	3					
			I <sub>OL</sub> = 1 mA	25°C		0.18	0.25			
				Full range			0.35			
			I <sub>OL</sub> = 20 mA	25°C		0.35	0.39			
			IOT = 20 IIIX	Full range			0.45			
Vol	Low-level output voltage	V <sub>IC</sub> = 2.5 V	I <sub>OL</sub> = 35 mA	25°C		0.43	0.55	V		
			IOL = 35 IIIA	Full range			0.7			
			25°C		0.45	0.63				
			I <sub>OL</sub> = 50 mA	−40°C to 85°C			0.7			
	Chart airquit autout autrant	Sourcing		25°C		100		mA		
los	Short-circuit output current	Sinking		25°C		100		mA		
		$V_{OH} = 1.5 V$ from pc	ositive rail	25°C		57		A		
0	Output current	$V_{OI} = 0.5 V$ from ne	gative rail	25°C		55		mA		

<sup>†</sup> Full range is 0°C to 70°C for C suffix and -40°C to 125°C for I suffix. If not specified, full range is -40°C to 125°C.



# TLC080, TLC081, TLC082, TLC083, TLC084, TLC085, TLC08xA FAMILY OF WIDE-BANDWIDTH HIGH-OUTPUT-DRIVE SINGLE SUPPLY OPERATIONAL AMPLIFIERS SLOS254B – JUNE 1999 – REVISED NOVEMBER 1999

# electrical characteristics at specified free-air temperature, V<sub>DD</sub> = 5 V (unless otherwise noted) (continued)

	PARAMETER	TEST CON	DITIONS	T <sub>A</sub> †	MIN	TYP	MAX	UNIT
A. (D	Large-signal differential voltage		D. 40160	25°C	100	120		dB
AVD	amplification	V <sub>O(PP)</sub> = 3 V,	$R_L = 10 k\Omega$	Full range	100			uБ
ri(d)	Differential input resistance			25°C		1000		GΩ
CIC	Common-mode input capacitance	f = 10 kHz		25°C		22.9		pF
z <sub>o</sub>	Closed-loop output impedance	f = 10 kHz,	A <sub>V</sub> = 10	25°C		0.25		Ω
CMPD	R Common-mode rejection ratio	$V_{IC} = 0$ to 3 V,	R <sub>S</sub> = 50 Ω	25°C	100	140		dB
CMRR				Full range	100			uВ
kour	Supply voltage rejection ratio	$V_{DD} = 4.5 \text{ V to } 16 \text{ V},$	$V_{IC} = V_{DD}/2$ ,	25°C	95	130		dB
<sup>k</sup> SVR	$(\Delta V_{DD} / \Delta V_{IO})$	No load	-	Full range	95			uБ
1	Supply current		No load	25°C		1.8	2.5	mA
IDD	(per channel)	V <sub>O</sub> = 2.5 V,	100 1000	Full range			3.5	mA
V <sub>(ON)</sub>	Turnon voltage level	Relative to GND		25°C		1.41		V
V(OFF)	Turnoff voltage level	Relative to GND		25°C		1.4		V
IDD(SHDN)	Supply current in shutdown mode (per channel)	<u>SHDN</u> ≤ 1.45 V		25°C		125	200	μA
(אוטחפושטי)	(TLC080, TLC083, TLC085)	511D14 2 1.45 V		Full range			250	μη

<sup>†</sup> Full range is 0°C to 70°C for C suffix and -40°C to 125°C for I suffix. If not specified, full range is -40°C to 125°C.



SLOS254B – JUNE 1999 – REVISED NOVEMBER 1999

	PARAMETER	TEST CONDI	TIONS	T <sub>A</sub> †	MIN	TYP	MAX	UNIT
SR+	Positive slew rate at unity gain	V <sub>O(PP)</sub> = 0.8 V,	C <sub>L</sub> = 50 pF,	25°C	10	16		V/us
SK+	Positive siew fate at unity gain	$R_L = 10 k\Omega$	_	Full range	9.5			v/µs
SR-	Negative slew rate at unity gain	V <sub>O(PP)</sub> = 0.8 V,	CL = 50 pF,	25°C	12.5	19		V/µs
511-	Negative siew rate at unity gain	R <sub>L</sub> = 10 kΩ		Full range	10			ν/μ5
Vn	Equivalent input noise voltage	f = 100 Hz		25°C		12		nV/√Hz
۷n	Equivalent input noise voltage	f = 1 kHz		25°C		8.5		
I <sub>n</sub>	Equivalent input noise current	f = 1 kHz		25°C		0.6		fA/√Hz
		V <sub>O(PP)</sub> = 3 V,	$A_V = 1$			0.002%		
THD + N	Total harmonic distortion plus noise	$R_{L} = 10 \text{ k}\Omega$ and 250 $\Omega$ ,	A <sub>V</sub> = 10	25°C		0.012%		
		f = 1 kHz	A <sub>V</sub> = 100			0.085%		
<sup>t</sup> (on)	Amplifier turnon time‡	Rι = 10 kΩ		25°C		0.15		μs
<sup>t</sup> (off)	Amplifier turnoff time <sup>‡</sup>			25°C		1.3		μs
	Gain-bandwidth product	f = 10 kHz,	$R_L = 10 \ k\Omega$	25°C		10		MHz
		V(STEP)PP = 1 V, A <sub>V</sub> = -1,	0.1%			0.18		
ts	Settling time	$C_L = 10 \text{ pF},$ $R_L = 10 \text{ k}\Omega$	0.01%	25°C		0.39		μs
'S		V(STEP)PP = 1 V, $A_V = -1,$	0.1%	20 0		0.18		
		$C_L = 47 \text{ pF},$ $R_L = 10 \text{ k}\Omega$	0.01%			0.39		
±		RL = 10 kΩ,	CL = 50 pF	25°C		32°		
<sup>¢</sup> m	Phase margin	R <sub>L</sub> = 10 kΩ,	C <sub>L</sub> = 0 pF			40°		
		R <sub>L</sub> = 10 kΩ,	C <sub>L</sub> = 50 pF	25°C		2.2		dB
	Gain margin	$R_{I} = 10 k\Omega$ ,	$C_{I} = 0 pF$	25.0		3.3		uБ

#### . . . а. - . . . . •• . . .. . . . . . • • . . .

<sup>†</sup> Full range is 0°C to 70°C for C suffix and –40°C to 125°C for I suffix. If not specified, full range is –40°C to 125°C.

<sup>‡</sup> Disable time and enable time are defined as the interval between application of the logic signal to SHDN and the point at which the supply current has reached half its final value.



# TLC080, TLC081, TLC082, TLC083, TLC084, TLC085, TLC08xA FAMILY OF WIDE-BANDWIDTH HIGH-OUTPUT-DRIVE SINGLE SUPPLY OPERATIONAL AMPLIFIERS SLOS254B – JUNE 1999 – REVISED NOVEMBER 1999

# electrical characteristics at specified free-air temperature, V<sub>DD</sub> = 12 V (unless otherwise noted)

	PARAMETER	TEST CO	NDITIONS	TA <sup>†</sup>	MIN	TYP	MAX	UNIT		
			TI C080/4/0/2	25°C		60	1000			
			TLC080/1/2/3	Full range			1500			
			TI 0000/4/0/0A	25°C		20	750			
. ,		V <sub>DD</sub> = 12 V	TLC080/1/2/3A	Full range			1000			
VIO	Input offset voltage	$V_{IC} = 6,$	TI 000 1/5	25°C		390	1900	μV		
		V <sub>O</sub> = 6,	TLC084/5	Full range			3000			
		R <sub>S</sub> = 50 Ω	<b>T</b> I 000 1/51	25°C		390	1400			
			TLC084/5A	Full range			2000			
αΛΙΟ	Temperature coefficient of input offset voltage					1.2		μV/°C		
				25°C		1.5	50			
IIO	Input offset current	V <sub>DD</sub> = 12 V	TLC08xC				100	pА		
		$V_{IC} = 6,$	TLC08xI	Full range			700			
		V <sub>O</sub> = 6,		25°C		2	50			
IIB	Input bias current	R <sub>S</sub> = 50 Ω	TLC08xC				100	pА		
			TLC08xI	- Full range			700			
VICR Common-mode input voltage range	CMRR > 70 dB	R <sub>S</sub> = 50 Ω	25°C	0 to 10.5						
		CMRR > 52 dB	R <sub>S</sub> = 50 Ω	Full range	0 to 10.5			V		
				25°C	11.1	11.2				
			$I_{OH} = -1 \text{ mA}$	Full range	11					
						25°C	10.8	11		
					I <sub>OH</sub> = -20 mA	Full range	10.7			
Vон	High-level output voltage	V <sub>IC</sub> = 6 V		25°C	10.6	10.7		V		
			$I_{OH} = -35 \text{ mA}$	Full range	10.3					
				25°C	10.3	10.5				
			I <sub>OH</sub> = -50 mA	-40°C to 85°C	10.2					
			1 1	25°C		0.17	0.25			
			I <sub>OL</sub> = 1 mA	Full range			0.35			
			1	25°C		0.35	0.45			
			1 <sub>OL</sub> = 20 mA	Full range			0.5			
Vol	Low-level output voltage	VIC = 6 V	1 05 A	25°C		0.4	0.52	V		
			1 <sub>OL</sub> = 35 mA	Full range			0.6			
			25°C		0.45	0.6				
			I <sub>OL</sub> = 50 mA	–40°C to 85°C			0.65			
	Chart aireuit autrut aurrent	Sourcing		25°C		150				
los	Short-circuit output current	Sinking		25°C		150		mA		
	Outrast aurorat	$V_{OH} = 1.5 V$ from pc	sitive rail	25°C		57				
1 <sub>0</sub>	Output current	$V_{OI} = 0.5 \text{ V from ne}$		25°C		55		mA		

<sup>†</sup> Full range is 0°C to 70°C for C suffix and -40°C to 125°C for I suffix. If not specified, full range is -40°C to 125°C.



SLOS254B – JUNE 1999 – REVISED NOVEMBER 1999

### electrical characteristics at specified free-air temperature, V<sub>DD</sub> = 12 V (unless otherwise noted) (continued)

	PARAMETER	TEST CON	DITIONS	T <sub>A</sub> †	MIN	TYP	MAX	UNIT
A. (=	Large-signal differential voltage		D 4010	25°C	120	140		dB
AVD	amplification	VO(PP) = 8 V,	$R_L = 10 \ k\Omega$	Full range	120			αв
ri(d)	Differential input resistance			25°C		1000		GΩ
C <sub>IC</sub>	Common-mode input capacitance	f = 10 kHz		25°C		21.6		pF
z <sub>0</sub>	Closed-loop output impedance	f = 10 kHz,	A <sub>V</sub> = 10	25°C		0.25		Ω
CMDD	Common-mode rejection ratio $V_{IC} =$	$V_{IC} = 0$ to 10 V, $R_S = 50 \Omega$	25°C	100	140		dB	
CMRR			NS = 50 32	Full range	100			uВ
kovo	Supply voltage rejection ratio	V <sub>DD</sub> = 4.5 V to 16 V,	$V_{IC} = V_{DD}/2$ ,	25°C	95	130		dB
<b>k</b> SVR	$(\Delta V_{DD} / \Delta V_{IO})$	No load		Full range	95			αв
1	Supply current		Nalaad	25°C		1.9	2.9	A
DD	(per channel)	V <sub>O</sub> = 7.5 V,	No load	Full range			3.5	mA
V <sub>(ON)</sub>	Turnon voltage level	Relative to GND		25°C		1.39		V
V(OFF)	Turnoff voltage level	Relative to GND		25°C		1.38		V
IDD(SHDN)	Supply current in shutdown mode (TLC080, TLC083,	<u>SHDN</u> ≤ 1.45 V		25°C		125	200	μA
.00(300N)	TLC085) (per channel)			Full range			250	puri

<sup>†</sup> Full range is 0°C to 70°C for C suffix and –40°C to 125°C for I suffix. If not specified, full range is –40°C to 125°C.



SLOS254B – JUNE 1999 – REVISED NOVEMBER 1999

# operating characteristics at specified free-air temperature, V<sub>DD</sub> = 12 V (unless otherwise noted)

	PARAMETER	TEST CONDI	TIONS	T <sub>A</sub> †	MIN	TYP	MAX	UNIT
SR+	Positive slew rate at unity gain	V <sub>O(PP)</sub> = 2 V,	C <sub>L</sub> = 50 pF,	25°C	10	16		V/µs
		$R_L = 10 k\Omega$		Full range	9.5			
SR-	Negative slew rate at unity gain	V <sub>O(PP)</sub> = 2 V,	CL = 50 pF,	25°C	12.5	19		V/µs
		$R_L = 10 k\Omega$		Full range	10			
v <sub>n</sub>	Equivalent input noise voltage	f = 100 Hz		25°C		14		nV/√Hz
		f = 1 kHz		25°C		8.5		
In	Equivalent input noise current	f = 1 kHz	_	25°C 0.6			fA/√Hz	
THD + N	Total harmonic distortion plus noise	$V_{O(PP)} = 8 \text{ V},$ $R_L = 10 \text{ k}\Omega \text{ and } 250 \Omega,$ f = 1  kHz	$A_V = 1$	25°C		0.002%		
			A <sub>V</sub> = 10			0.005%		
			A <sub>V</sub> = 100			0.022%		
t(on)	Amplifier turnon time‡	R <sub>I</sub> = 10 kΩ		25°C		0.47		μs
<sup>t</sup> (off)	Amplifier turnoff time <sup>‡</sup>	$K_{L} = 10 \text{ ksz}$	25°C		2.5		μs	
	Gain-bandwidth product	f = 10 kHz,	$R_L = 10 \ k\Omega$	25°C		10		MHz
t <sub>s</sub>	Settling time	$\label{eq:V(STEP)PP} \begin{array}{l} V(STEP)PP = 1 \ V, \\ A_{V} = -1, \\ C_{L} = 10 \ pF, \\ R_{L} = 10 \ k\Omega \end{array}$	0.1%	25°C		0.17		μs
			0.01%			0.22		
		V(STEP)PP = 1 V, $A_V = -1,$	0.1%	200		0.17		
		$C_L = 47 \text{ pF},$ $R_L = 10 \text{ k}\Omega$	0.01%			0.29		
<sup>¢</sup> m	Phase margin	R <sub>L</sub> = 10 kΩ,	C <sub>L</sub> = 50 pF	25°C		37°		
		R <sub>L</sub> = 10 kΩ,	$C_L = 0 pF$	23.0		42°		
	Gain margin	R <sub>L</sub> = 10 kΩ,	C <sub>L</sub> = 50 pF	25°C		3.1		dB
		R <sub>L</sub> = 10 kΩ,	$C_{I} = 0  pF$	25.0		4		

<sup>†</sup> Full range is 0°C to 70°C for C suffix and –40°C to 125°C for I suffix. If not specified, full range is –40°C to 125°C.

<sup>‡</sup> Disable time and enable time are defined as the interval between application of the logic signal to SHDN and the point at which the supply current has reached half its final value.



# TLC080, TLC081, TLC082, TLC083, TLC084, TLC085, TLC08xA FAMILY OF WIDE-BANDWIDTH HIGH-OUTPUT-DRIVE SINGLE SUPPLY OPERATIONAL AMPLIFIERS SLOS254B – JUNE 1999 – REVISED NOVEMBER 1999

# **TYPICAL CHARACTERISTICS**

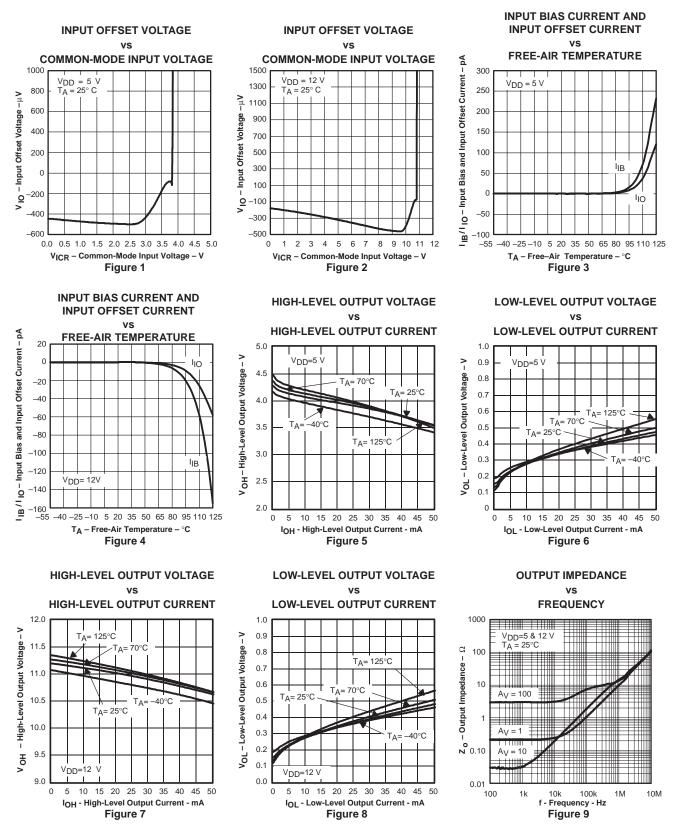
# **Table of Graphs**

			FIGURE
VIO	Input offset voltage	vs Common-mode input voltage	1, 2
1 <sub>10</sub>	Input offset current	vs Free-air temperature	3, 4
IIB	Input bias current	vs Free-air temperature	3, 4
VOH	High-level output voltage	vs High-level output current	5, 7
VOL	Low-level output voltage	vs Low-level output current	6, 8
Z <sub>0</sub>	Output impedance	vs Frequency	9
IDD	Supply current	vs Supply voltage	10
PSRR	Power supply rejection ratio	vs Frequency	11
CMRR	Common-mode rejection ratio	vs Frequency	12
V <sub>n</sub>	Equivalent input noise voltage	vs Frequency	13
V <sub>O(PP)</sub>	Peak-to-peak output voltage	vs Frequency	14, 15
	Crosstalk	vs Frequency	16
	Differential voltage gain	vs Frequency	17, 18
	Phase	vs Frequency	17, 18
<sup>¢</sup> m	Phase margin	vs Load capacitance	19, 20
	Gain margin	vs Load capacitance	21, 22
	Gain-bandwidth product	vs Supply voltage	23
SR	Slew rate	vs Supply voltage vs Free-air temperature	24 25, 26
	Total homeonic distortion plus pairs	vs Frequency	27, 28
THD + N	Total harmonic distortion plus noise	vs Peak-to-peak output voltage	29, 30
	Large-signal follower pulse response	vs Time	31, 32
	Small-signal follower pulse response	vs Time	33
	Large-signal inverting pulse response	vs Time	34, 35
	Small-signal inverting pulse response	vs Time	36
	Shutdown forward isolation	vs Frequency	37, 38
	Shutdown reverse isolation	vs Frequency	39, 40
	Chutdowe owerky owerest	vs Supply voltage	41
	Shutdown supply current	vs Free-air temperature	42
	Shutdown pulse		43, 44

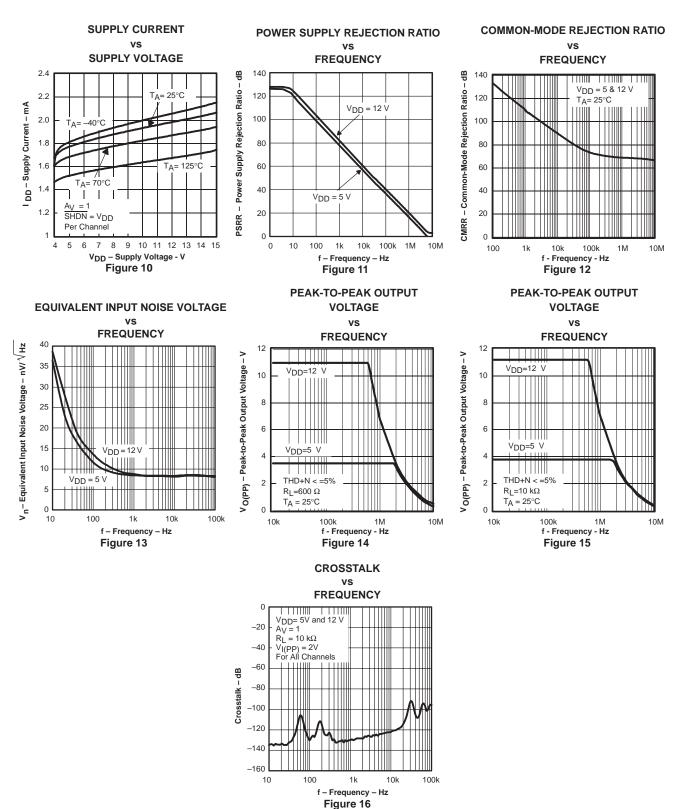


SLOS254B - JUNE 1999 - REVISED NOVEMBER 1999





SLOS254B – JUNE 1999 – REVISED NOVEMBER 1999

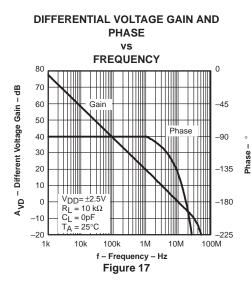


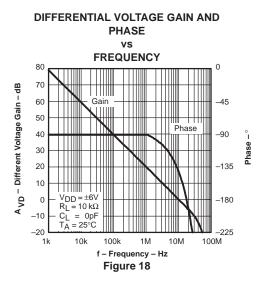
#### **TYPICAL CHARACTERISTICS**

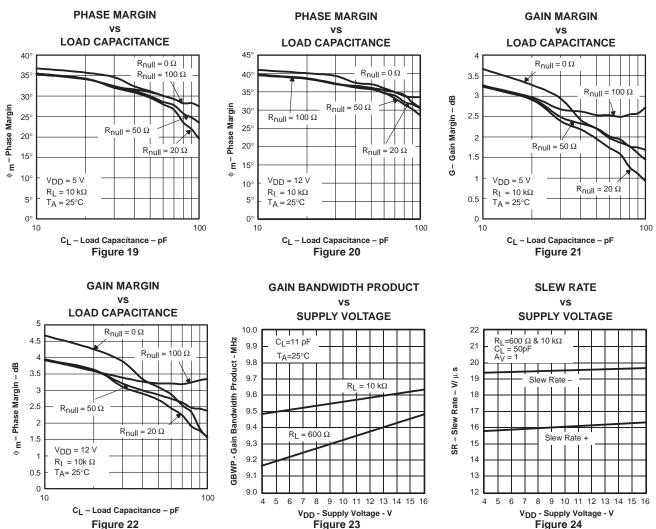


SLOS254B - JUNE 1999 - REVISED NOVEMBER 1999



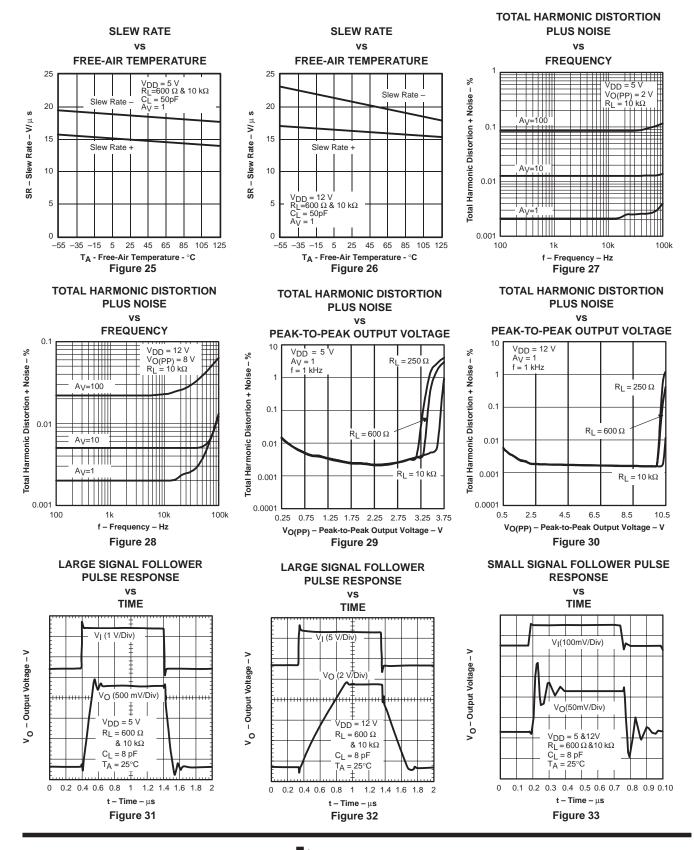




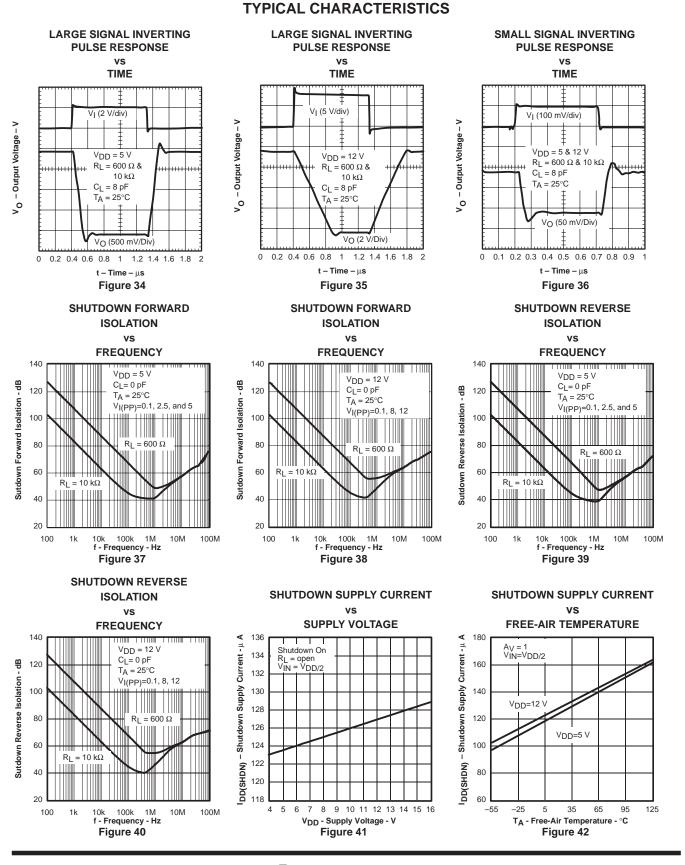


SLOS254B – JUNE 1999 – REVISED NOVEMBER 1999



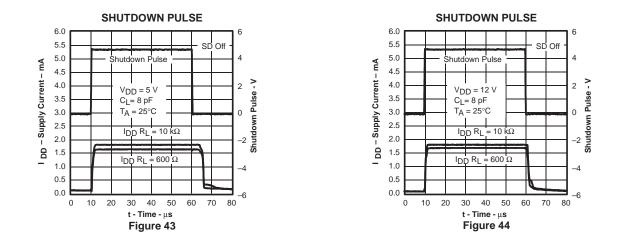


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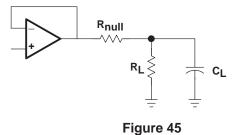


SLOS254B - JUNE 1999 - REVISED NOVEMBER 1999





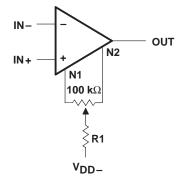
#### PARAMETER MEASUREMENT INFORMATION



### **APPLICATION INFORMATION**

#### input offset voltage null circuit

The TLC080 and TLC081 has an input offset nulling function. Refer to Figure 46 for the diagram.



NOTE A: If R1 = 5.6 k $\Omega$  for offset voltage adjustment of ±10 mV. If R1 = 20 k $\Omega$  for offset voltage adjustment of ±3 mV.

Figure 46. Input Offset Voltage Null Circuit



SLOS254B - JUNE 1999 - REVISED NOVEMBER 1999

### **APPLICATION INFORMATION**

#### driving a capacitive load

When the amplifier is configured in this manner, capacitive loading directly on the output will decrease the device's phase margin leading to high frequency ringing or oscillations. Therefore, for capacitive loads of greater than 10 pF, it is recommended that a resistor be placed in series ( $R_{NULL}$ ) with the output of the amplifier, as shown in Figure 47. A minimum value of 20  $\Omega$  should work well for most applications.

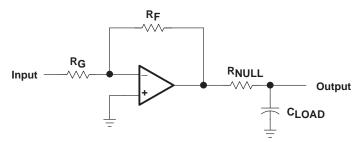


Figure 47. Driving a Capacitive Load

### offset voltage

The output offset voltage, ( $V_{OO}$ ) is the sum of the input offset voltage ( $V_{IO}$ ) and both input bias currents ( $I_{IB}$ ) times the corresponding gains. The following schematic and formula can be used to calculate the output offset voltage:

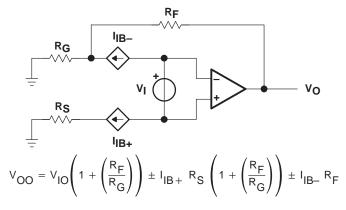


Figure 48. Output Offset Voltage Model



SLOS254B - JUNE 1999 - REVISED NOVEMBER 1999

#### **APPLICATION INFORMATION**

#### high speed CMOS input amplifiers

The TLC08x is a family of high-speed low-noise CMOS input operational amplifiers and has an input capacitance of the order of 20 pF. Any resistor used in the feedback path adds a pole in the transfer function equivalent to the input capacitance multiplied by the combination of source resistance and feedback resistance. For example, a gain of –10, source resistance of 1 k $\Omega$  and a feedback resistance of 10 k $\Omega$  adds an additional pole at approximately 8 MHz. This is more apparent with CMOS amplifiers than bipolar amplifiers due to their greater input capacitance.

This is of little consequence on slower CMOS amplifiers, as this pole normally occurs at frequencies above their unity-gain bandwidth. However, the TLC08x with its 10-MHz bandwidth means that this pole normally occurs at frequencies where there is on the order of 5dB gain left and the phase shift adds considerably.

The effect of this pole is the strongest with large feedback resistances at small closed loop gains. As the feedback resistance is increased, the gain peaking increases at a lower frequency and the 180° phase shift crossover point also moves down in frequency, decreasing the phase margin.

For the TLC08x, the maximum feedback resistor recommended is 5 k $\Omega$ , larger resistances can be used but a capacitor in parallel with the feedback resistor is recommended to counter the effects of the input capacitance pole.

The TLC083 with a 1-V step response has an 80% overshoot with a natural frequency of 3.5 MHz when configured as a unity gain buffer and with a  $10-k\Omega$  feedback resistor. By adding a 10-pF capacitor in parallel with the feedback resistor, the overshoot is reduced to 40% and eliminates the natural frequency, resulting in a much faster settling time (see Figure 49). The 10-pF capacitor was chosen for convenience only.

Load capacitance had little effect on these measurements due to the excellent output drive capability of the TLC08x.

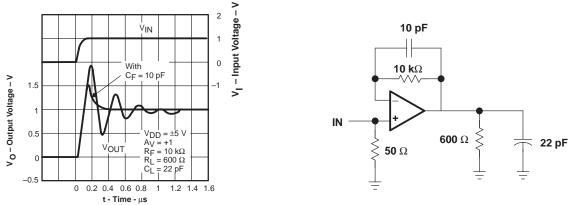


Figure 49. 1-V Step Response



SLOS254B - JUNE 1999 - REVISED NOVEMBER 1999

### **APPLICATION INFORMATION**

#### general configurations

When receiving low-level signals, limiting the bandwidth of the incoming signals into the system is often required. The simplest way to accomplish this is to place an RC filter at the noninverting terminal of the amplifer (see Figure 50).

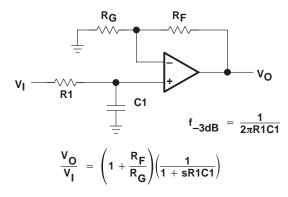


Figure 50. Single-Pole Low-Pass Filter

If even more attenuation is needed, a multiple pole filter is required. The Sallen-Key filter can be used for this task. For best results, the amplifier should have a bandwidth that is 8 to 10 times the filter frequency bandwidth. Failure to do this can result in phase shift of the amplifier.

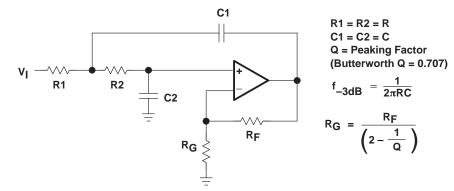


Figure 51. 2-Pole Low-Pass Sallen-Key Filter

SLOS254B - JUNE 1999 - REVISED NOVEMBER 1999

#### **APPLICATION INFORMATION**

#### shutdown function

Three members of the TLC08x family (TLC080/3/5) have a shutdown terminal (SHDN) for conserving battery life in portable applications. When the shutdown terminal is tied low, the supply current is reduced to 16 nA/channel, the amplifier is disabled, and the outputs are placed in a high-impedance mode. To enable the amplifier, the shutdown terminal can either be left floating or pulled high. When the shutdown terminal is left floating, care should be taken to ensure that parasitic leakage current at the shutdown terminal does not inadvertently place the operational amplifier into shutdown. The shutdown terminal threshold is always referenced to V<sub>DD</sub>/2. Therefore, when operating the device with split supply voltages (e.g.  $\pm 2.5$  V), the shutdown terminal needs to be pulled to V<sub>DD</sub>- (not GND) to disable the operational amplifier.

The amplifier's output with a shutdown pulse is shown in Figures 43 and 44. The amplifier is powered with a single 5-V supply and is configured as noninverting with a gain of 5. The amplifier turnon and turnoff times are measured from the 50% point of the shutdown pulse to the 50% point of the output waveform. The times for the single, dual, and quad are listed in the data tables.

Figures 37, 38, 39, and 40 show the amplifier's forward and reverse isolation in shutdown. The operational amplifier is configured as a voltage follower ( $A_V = 1$ ). The isolation performance is plotted across frequency using 0.1 V<sub>PP</sub>, 2.5 V<sub>PP</sub>, and 5 V<sub>PP</sub> input signals at ±2.5 V supplies and 0.1 V<sub>PP</sub>, 8 V<sub>PP</sub>, and 12 V<sub>PP</sub> input signals at ±6 V supplies.

#### circuit layout considerations

To achieve the levels of high performance of the TLC08x, follow proper printed-circuit board design techniques. A general set of guidelines is given in the following.

- Ground planes It is highly recommended that a ground plane be used on the board to provide all components with a low inductive ground connection. However, in the areas of the amplifier inputs and output, the ground plane can be removed to minimize the stray capacitance.
- Proper power supply decoupling Use a 6.8-µF tantalum capacitor in parallel with a 0.1-µF ceramic capacitor on each supply terminal. It may be possible to share the tantalum among several amplifiers depending on the application, but a 0.1-µF ceramic capacitor should always be used on the supply terminal of every amplifier. In addition, the 0.1-µF capacitor should be placed as close as possible to the supply terminal. As this distance increases, the inductance in the connecting trace makes the capacitor less effective. The designer should strive for distances of less than 0.1 inches between the device power terminals and the ceramic capacitors.
- Sockets Sockets can be used but are not recommended. The additional lead inductance in the socket pins
  will often lead to stability problems. Surface-mount packages soldered directly to the printed-circuit board
  is the best implementation.
- Short trace runs/compact part placements Optimum high performance is achieved when stray series inductance has been minimized. To realize this, the circuit layout should be made as compact as possible, thereby minimizing the length of all trace runs. Particular attention should be paid to the inverting input of the amplifier. Its length should be kept as short as possible. This will help to minimize stray capacitance at the input of the amplifier.
- Surface-mount passive components Using surface-mount passive components is recommended for high
  performance amplifier circuits for several reasons. First, because of the extremely low lead inductance of
  surface-mount components, the problem with stray series inductance is greatly reduced. Second, the small
  size of surface-mount components naturally leads to a more compact layout thereby minimizing both stray
  inductance and capacitance. If leaded components are used, it is recommended that the lead lengths be
  kept as short as possible.



SLOS254B – JUNE 1999 – REVISED NOVEMBER 1999

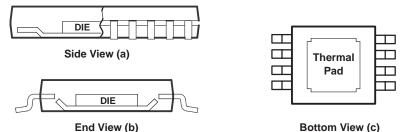
# **APPLICATION INFORMATION**

#### general PowerPAD<sup>™</sup> design considerations

The TLC08x is available in a thermally-enhanced PowerPAD family of packages. These packages are constructed using a downset leadframe upon which the die is mounted [see Figure 52(a) and Figure 52(b)]. This arrangement results in the lead frame being exposed as a thermal pad on the underside of the package [see Figure 52(c)]. Because this thermal pad has direct thermal contact with the die, excellent thermal performance can be achieved by providing a good thermal path away from the thermal pad.

The PowerPAD package allows for both assembly and thermal management in one manufacturing operation. During the surface-mount solder operation (when the leads are being soldered), the thermal pad can also be soldered to a copper area underneath the package. Through the use of thermal paths within this copper area, heat can be conducted away from the package into either a ground plane or other heat dissipating device.

The PowerPAD package represents a breakthrough in combining the small area and ease of assembly of surface mount with the, heretofore, awkward mechanical methods of heatsinking.



NOTE B: The thermal pad is electrically isolated from all terminals in the package.

Figure 52. Views of Thermally Enhanced DGN Package

Although there are many ways to properly heatsink the PowerPAD package, the following steps illustrate the recommended approach.

#### Thermal Pad Area

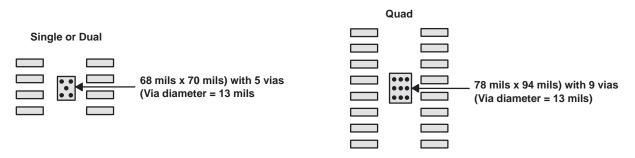


Figure 53. PowerPAD PCB Etch and Via Pattern

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SLOS254B - JUNE 1999 - REVISED NOVEMBER 1999

#### **APPLICATION INFORMATION**

#### general PowerPAD design considerations (continued)

- 1. Prepare the PCB with a top side etch pattern as shown in Figure 53. There should be etch for the leads as well as etch for the thermal pad.
- 2. Place five holes (dual) or nine holes (quad) in the area of the thermal pad. These holes should be 13 mils in diameter. Keep them small so that solder wicking through the holes is not a problem during reflow.
- 3. Additional vias may be placed anywhere along the thermal plane outside of the thermal pad area. This helps dissipate the heat generated by the TLC08x IC. These additional vias may be larger than the 13-mil diameter vias directly under the thermal pad. They can be larger because they are not in the thermal pad area to be soldered so that wicking is not a problem.
- 4. Connect all holes to the internal ground plane.
- 5. When connecting these holes to the ground plane, **do not** use the typical web or spoke via connection methodology. Web connections have a high thermal resistance connection that is useful for slowing the heat transfer during soldering operations. This makes the soldering of vias that have plane connections easier. In this application, however, low thermal resistance is desired for the most efficient heat transfer. Therefore, the holes under the TLC08x PowerPAD package should make their connection to the internal ground plane with a complete connection around the entire circumference of the plated-through hole.
- 6. The top-side solder mask should leave the terminals of the package and the thermal pad area with its five holes (dual) or nine holes (quad) exposed. The bottom-side solder mask should cover the five or nine holes of the thermal pad area. This prevents solder from being pulled away from the thermal pad area during the reflow process.
- 7. Apply solder paste to the exposed thermal pad area and all of the IC terminals.
- 8. With these preparatory steps in place, the TLC08x IC is simply placed in position and run through the solder reflow operation as any standard surface-mount component. This results in a part that is properly installed.

For a given  $\theta_{JA}$ , the maximum power dissipation is shown in Figure 54 and is calculated by the following formula:

$$\mathsf{P}_{\mathsf{D}} = \left(\frac{\mathsf{T}_{\mathsf{MAX}} - \mathsf{T}_{\mathsf{A}}}{\theta_{\mathsf{JA}}}\right)$$

Where:

P<sub>D</sub> = Maximum power dissipation of TLC08x IC (watts)

- $T_{MAX}$  = Absolute maximum junction temperature (150°C)
- $T_A$  = Free-ambient air temperature (°C)

 $\theta_{JA} = \theta_{JC} + \theta_{CA}$ 

 $\theta_{JC}$  = Thermal coefficient from junction to case

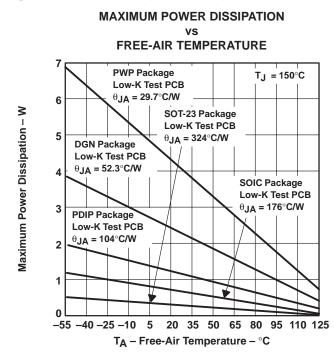
 $\theta_{CA}$  = Thermal coefficient from case to ambient air (°C/W)



SLOS254B – JUNE 1999 – REVISED NOVEMBER 1999

### **APPLICATION INFORMATION**

#### general PowerPAD design considerations (continued)



NOTE A: Results are with no air flow and using JEDEC Standard Low-K test PCB.

#### Figure 54. Maximum Power Dissipation vs Free-Air Temperature

The next consideration is the package constraints. The two sources of heat within an amplifier are quiescent power and output power. The designer should never forget about the quiescent heat generated within the device, especially muti-amplifier devices. Because these devices have linear output stages (Class A-B), most of the heat dissipation is at low output voltages with high output currents.

The other key factor when dealing with power dissipation is how the devices are mounted on the PCB. The PowerPAD devices are extremely useful for heat dissipation. But, the device should always be soldered to a copper plane to fully use the heat dissipation properties of the PowerPAD. The SOIC package, on the other hand, is highly dependent on how it is mounted on the PCB. As more trace and copper area is placed around the device,  $\theta_{JA}$  decreases and the heat dissipation capability increases. The currents and voltages shown in these graphs are for the total package. For the dual or quad amplifier packages, the sum of the RMS output currents and voltages should be used to choose the proper package.



SLOS254B - JUNE 1999 - REVISED NOVEMBER 1999

#### **APPLICATION INFORMATION**

#### macromodel information

Macromodel information provided was derived using Microsim *Parts*<sup>TM</sup>, the model generation software used with Microsim *PSpice*<sup>TM</sup>. The Boyle macromodel (see Note 1) and subcircuit in Figure 55 are generated using the TLC08x typical electrical and operating characteristics at  $T_A = 25^{\circ}$ C. Using this information, output simulations of the following key parameters can be generated to a tolerance of 20% (in most cases):

- Maximum positive output voltage swing
- Maximum negative output voltage swing
- Slew rate
- Quiescent power dissipation
- Input bias current
- Open-loop voltage amplification

- Unity-gain frequency
- Common-mode rejection ratio
- Phase margin
- DC output resistance
- AC output resistance
- Short-circuit output current limit

NOTE 1: G. R. Boyle, B. M. Cohn, D. O. Pederson, and J. E. Solomon, "Macromodeling of Integrated Circuit Operational Amplifiers," *IEEE Journal* of Solid-State Circuits, SC-9, 353 (1974).



SLOS254B – JUNE 1999 – REVISED NOVEMBER 1999

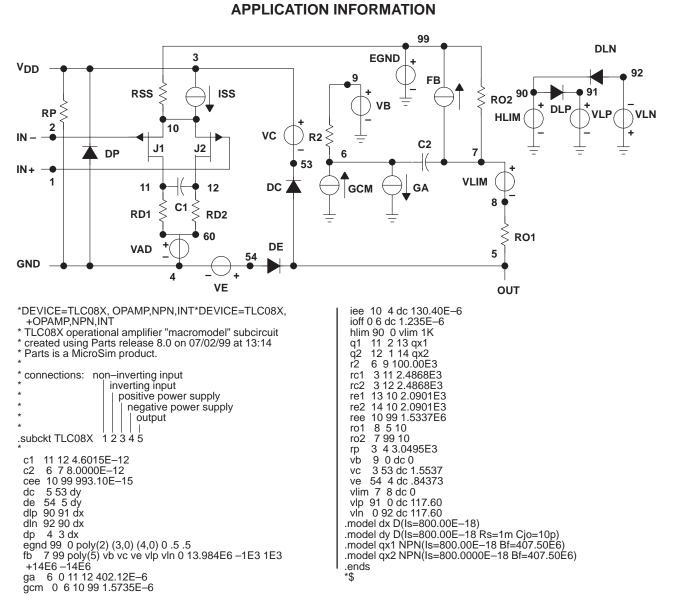


Figure 55. Boyle Macromodel and Subcircuit

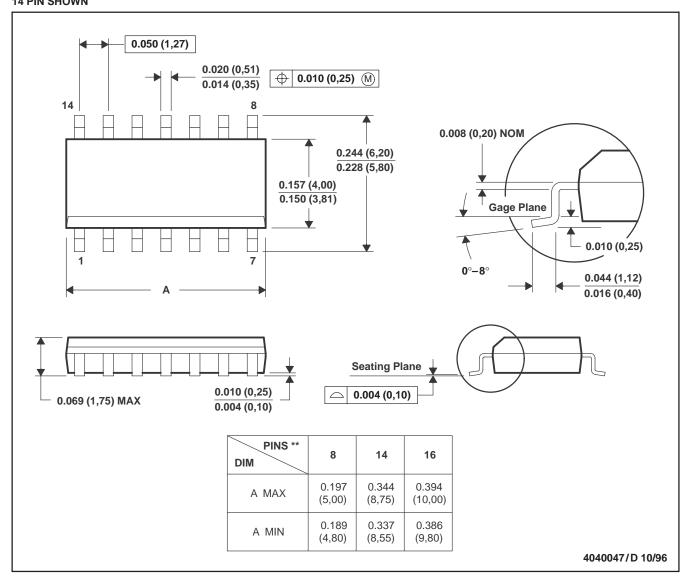


SLOS254B - JUNE 1999 - REVISED NOVEMBER 1999

#### **MECHANICAL DATA**

#### PLASTIC SMALL-OUTLINE PACKAGE

D (R-PDSO-G\*\*) 14 PIN SHOWN



NOTES: B. All linear dimensions are in inches (millimeters).

- C. This drawing is subject to change without notice.
- D. Body dimensions do not include mold flash or protrusion, not to exceed 0.006 (0,15).
- E. Falls within JEDEC MS-012

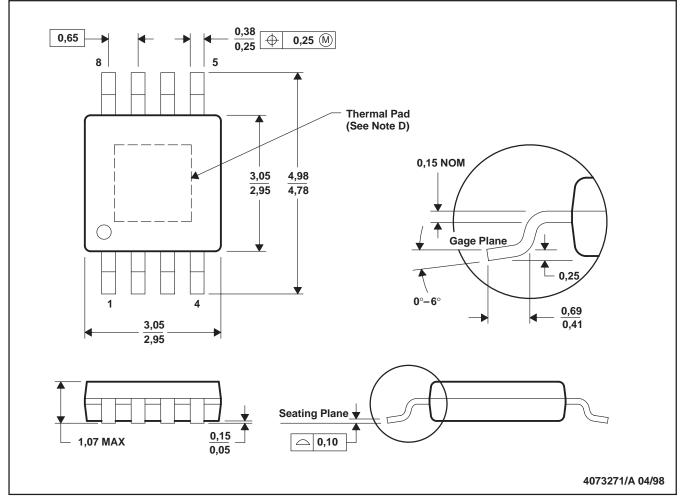


SLOS254B – JUNE 1999 – REVISED NOVEMBER 1999

#### **MECHANICAL INFORMATION**

#### DGN (S-PDSO-G8)

#### PowerPAD<sup>™</sup> PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions include mold flash or protrusions.
- D. The package thermal performance may be enhanced by attaching an external heat sink to the thermal pad. This pad is electrically and thermally connected to the backside of the die and possibly selected leads.
- E. Falls within JEDEC MO-187

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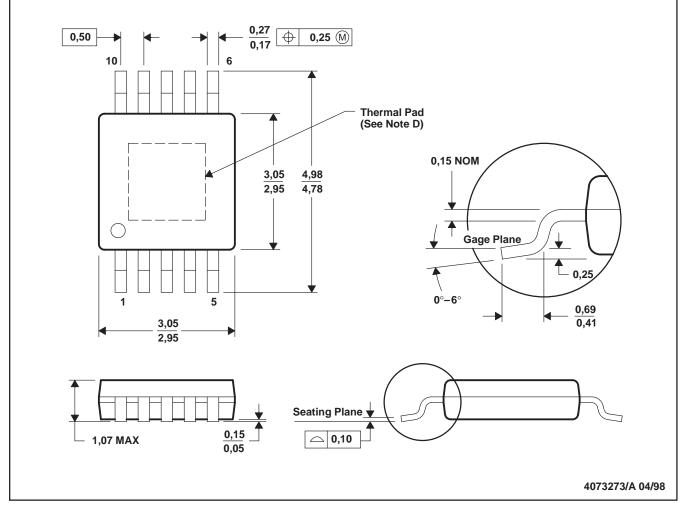


SLOS254B - JUNE 1999 - REVISED NOVEMBER 1999

#### **MECHANICAL INFORMATION**

#### DGQ (S-PDSO-G10)

#### PowerPAD™ PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion.
- D. The package thermal performance may be enhanced by bonding the thermal pad to an external thermal plane. This pad is electrically and thermally connected to the backside of the die and possibly selected leads.

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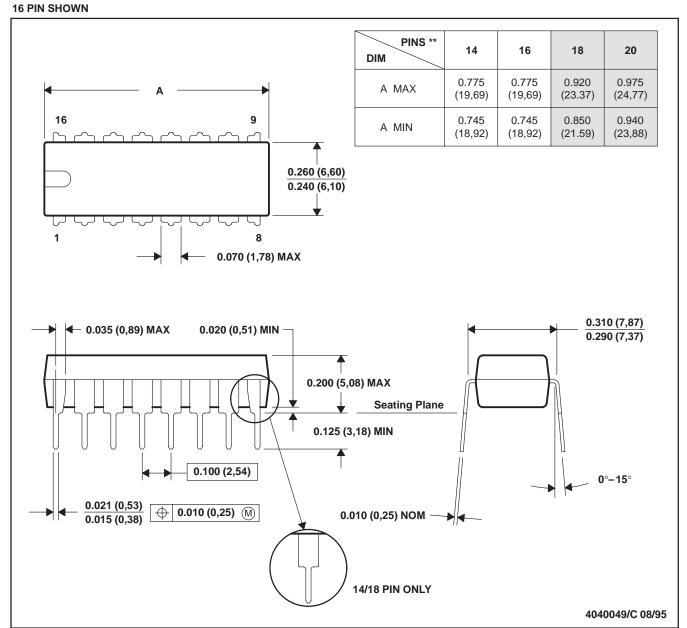


SLOS254B - JUNE 1999 - REVISED NOVEMBER 1999

### **MECHANICAL INFORMATION**

#### PLASTIC DUAL-IN-LINE PACKAGE

# N (R-PDIP-T\*\*)



NOTES: A. All linear dimensions are in inches (millimeters).

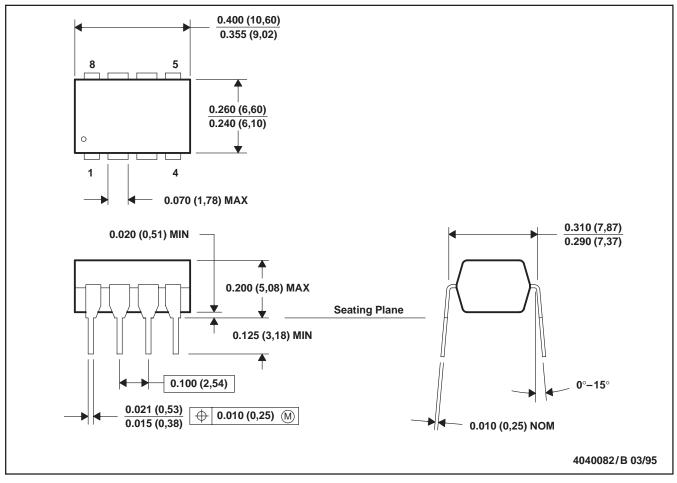
- B. This drawing is subject to change without notice.
- C. Falls within JEDEC MS-001 (20 pin package is shorter then MS-001.)



SLOS254B - JUNE 1999 - REVISED NOVEMBER 1999

#### **MECHANICAL INFORMATION**

#### PLASTIC DUAL-IN-LINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters). B. This drawing is subject to change without notice.

C. Falls within JEDEC MS-001

P (R-PDIP-T8)



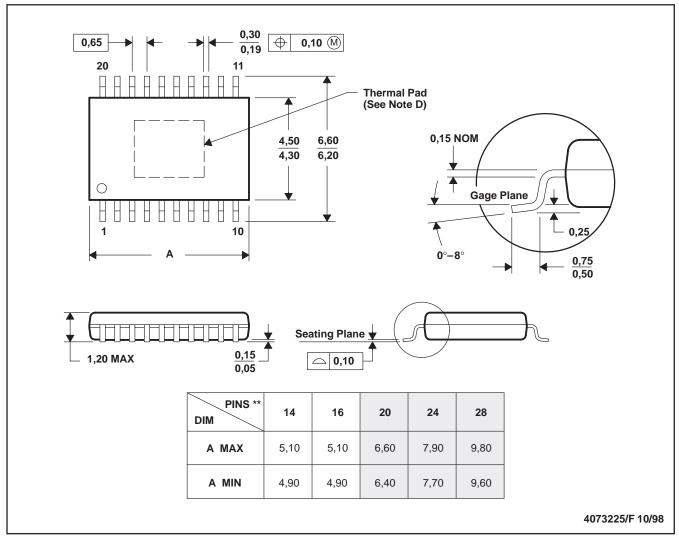
SLOS254B - JUNE 1999 - REVISED NOVEMBER 1999

#### **MECHANICAL INFORMATION**

PWP (R-PDSO-G\*\*)

PowerPAD<sup>™</sup> PLASTIC SMALL-OUTLINE





NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusions.
- D. The package thermal performance may be enhanced by bonding the thermal pad to an external thermal plane. This pad is electrically and thermally connected to the backside of the die and possibly selected leads.

E. Falls within JEDEC MO-153



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